
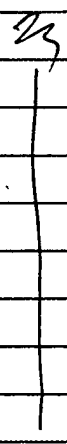

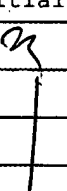



FORM PTO-1449 MODIFIED List of Patents and Publications Cited by Applicant (Use several sheets if necessary) U.S. Department of Commerce Patent and Trademark Office				Case No. LDC-791 3DIV		Serial No. 10/624,187	
				Applicant: Subelka et al			
				Filing Date July 22, 2003		Group 3732	
U. S. PATENT DOCUMENTS							
Examiner Initial		Document No.	Date	Name	Class	Subclass	
		4,107,845	8/78	Lee, Jr. et al	32	15	
		4,115,346	9/78	Gross et al	260	42.15	
		4,141,144	2/79	Lustgarten	32	15	
		4,226,622	10/80	Aliotta et al	75	251	
		4,350,532	9/82	Randklev	106	30	
		4,358,549	11/82	Randklev	523	117	
		4,360,693	11/82	Orlowski	560	220	
		4,375,967	3/83	Schaefer	433	199	
		4,379,695	4/83	Orlowski et al	433	217	
		4,381,918	5/83	Ehrnford	433	199	
FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document No.	Date	Country	Translation YES NO		
		34 16 083	10/85	DE		X	
		195 24 362	1/96	DE		X	
		0 053 442	5/93	EP		In English	
		0 159 887	7/94	EP		In English	
		0 222 899	4/92	EP		In English	
OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER <u>Tue Yoon</u> DATE CONSIDERED <u>7-22-05</u>							
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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U. S. PATENT DOCUMENTS																									
Examiner Initial		Document No.	Date	Name	Class	Subclass																			
M		4,387,240	6/83	Berg	556	440																			
		4,392,828	7/83	Ehrnford	433	217																			
		4,407,984	10/83	Ratcliffe et al	523	115																			
		4,490,115	12/84	Orlowski et al	433	199																			
		4,503,169	3/85	Randklev	523	117																			
		4,514,174	4/85	Dougherty et al	433	226																			
		4,514,342	4/85	Billington et al	260	952																			
		4,544,359	10/85	Waknine	523	115																			
	4,547,531	10/85	Waknine	523	116																				
M		4,636,533	1/87	Janda et al	522	14																			
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Examiner Initial		Document No.	Date	Country	Translation YES NO																				
M		0 368 657	8/93	EP			In English																		
		0 434 334	2/94	EP			In English																		
		0 475 239	3/92	EP			X																		
		0 509 516	3/97	EP			In English																		
M		0 530 926	3/93	EP			In English																		
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	Applicant: Subelka et al	
	Filing Date July 22, 2003	Group 3732

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Examiner Initial	Document No.	Date	Name	Class	Subclass
27	4,640,936	2/87	Janda et al	522	14
	4,649,165	3/87	Kuhlmann	523	116
	4,656,053	4/87	Angrick et al	427	53.1
	4,658,558	4/87	Verble	52	410
	4,675,941	6/87	Grass	16	295
	4,758,612	7/88	Wilson et al	524	5
	4,814,362	3/89	Billington et al	523	117
	4,816,495	3/89	Blackwell et al	522	14
27	5,009,597	4/91	Schaefer	433	212.1
	5,079,277	1/92	Wilson et al	523	116

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Examiner Initial	Document No.	Date	Country	Translation YES	Translation NO
3	0 839 511	5/98	EP		In English
3	92/08419	5/92	WO		In English
3	96/03090	2/96	WO		X

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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Examiner Initial	Document No.	Date	Name	Class	Subclass
24	5,089,051	2/92	Eppinger et al	106	35
	5,106,304	4/92	Chronister	433	228.1
	5,218,070	6/93	Blackwell	526	318
	5,228,907	7/93	Eppinger et al	106	35
	5,252,697	10/93	Jacobs et al	528	60
	5,338,773	8/94	Lu et al	523	116
	5,350,782	9/94	Sasaki et al	523	116
	5,354,785	10/94	Rheinberger et al	523	116
	5,356,951	10/94	Yearn et al	523	116
25	5,378,737	1/95	Jacobs et al	523	116

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Examiner Initial	Document No.	Date	Name	Class	Subclass	
	5,418,262	5/95	Göbel	523	116	
	5,425,640	6/95	Scharf	433	215	
	5,538,129	7/96	Chester et al	206	63.5	
	5,547,379	8/96	Hasel	433	212.1	
	5,548,001	8/96	Podszun et al	523	116	
	5,548,002	8/96	Schwabe et al	523	118	
	5,609,675	3/97	Noritake et al	106	35	
	5,621,119	4/97	Podszun et al	549	229	
	5,645,429	7/97	Blackwell et al	433	217.1	
	5,707,440	1/98	Hengchang et al	106	485	

FOREIGN PATENT DOCUMENTS					
Examiner Initial	Document No.	Date	Country	Translation	
				YES	NO

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U. S. PATENT DOCUMENTS							
Examiner Initial		Document No.	Date	Name	Class	Subclass	
2		5,710,194	1/98	Hammesfahr et al	523	116	
		5,846,075	12/98	Suh et al	433	23	
		5,944,527	8/99	Hasel	433	212.1	
		6,353,040	3/02	Subelka et al	523	116	
		Re. 32,073	1/86	Randklev	523	117	
2		Re. 32,299	12/86	Randklev	501	59	
FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document No.	Date	Country	Translation YES NO		
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